



浙江世菱半导体有限公司
ZHEJIANG SHILING SEMICONDUCTOR CO.,LTD.

产品规格书

Specification of products

产品名称：可控硅模块

产品型号：MTC350A-Y03

浙江世菱半导体有限公司
ZHEJIANG SHILING SEMICONDUCTOR CO., LTD.

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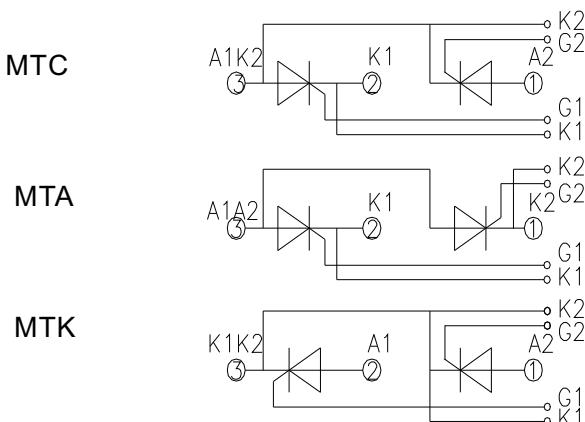
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拟制	审核	核准
林益龙	曹剑龙	宗瑞

SYMBOL	CHARACTERISTIC	TEST CONDITIONS	T _j (°C)	VALUE			UNIT
				Min	Type	Max	
I _{T(AV)}	Mean on-state current	180° half sine wave 50Hz Single side cooled, T _c =85°C	125			300	A
I _{T(RMS)}	RMS on-state current	Single side cooled, T _c =85°C	125			471	A
V _{DRM} V _{RRM}	Repetitive peak off-state voltage Repetitive peak reverse voltage	V _{DRM} &V _{RRM} tp=10ms V _{DsM} &V _{RsM} = V _{DRM} &V _{RRM} +200V respectively	125		4500		V
I _{DRM} I _{RRM}	Repetitive peak current	at V _{DRM} at V _{RRM}	125			30	mA
I _{TSM}	Surge on-state current	10ms half sinewave	125			7.20	KA
I ² t	I ² T for fusing coordination	V _R =60%V _{RRM}				264	As*10 ³
V _{TO}	Threshold voltage		125			0.80	V
r _T	On-state slop resistance					1.27	mΩ
V _{TM}	Peak on-state voltage	I _M =900A	125			1.50	V
dv/dt	Critical rate of rise of off-state voltage	V _{DM} =67%V _{DRM}	125			800	V/ μs
di/dt	Critical rate of rise of on-state current	From 67%V _{DRM} To 600A, Gate source 1.5A t _r ≤0.5 μ sRepetitive	125			150	A/ μs
I _{GT}	Gate trigger current		25	30		180	mA
V _{GT}	Gate trigger voltage	V _A =12V, I _A =1A		1.0		2.5	V
I _H	Holding current			20		100	mA
V _{GD}	Non-trigger gate voltage	At 67%V _{DRM}	125			0.2	V
R _{th(j-c)}	Thermal resistance Junction to heatsink	At 180° sine Single side cooled				0.140	°C /W
V _{iso}	Isolation voltage	50Hz, RM. S, t=1min, I _{iso} : 1mA (MAX)	5000				V
F _m	Thermal connection torque (M8)				7.0		N.m
	Mounting torque (M6)				5.0		N.m
T _{stg}	Stored temperature			-40		140	°C
W _t	Weight				900		g
Outline							

OUTLINE DRAWING & CIRCUIT DIAGRAM



Rating and Characteristic

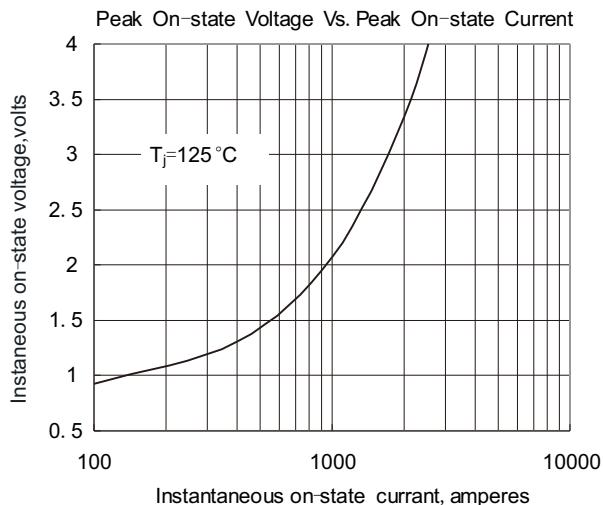


Fig. 1

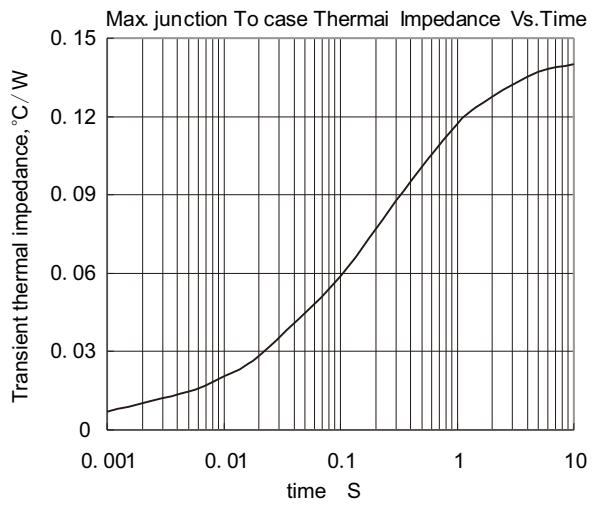


Fig. 2

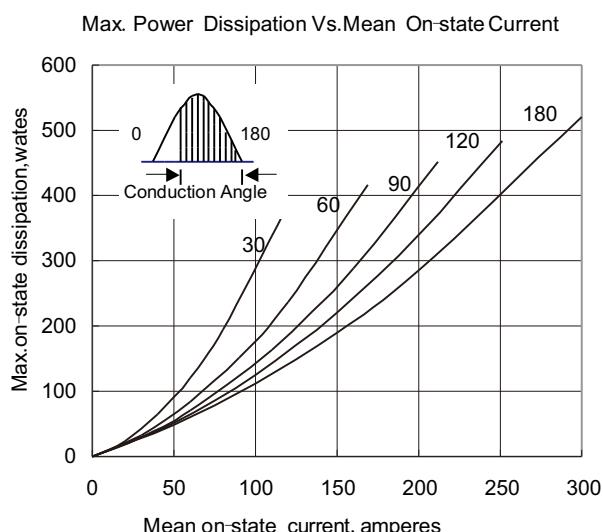


Fig. 3

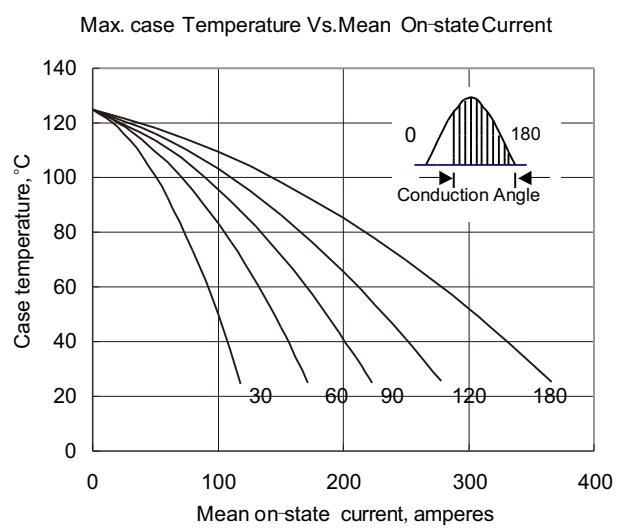


Fig. 4

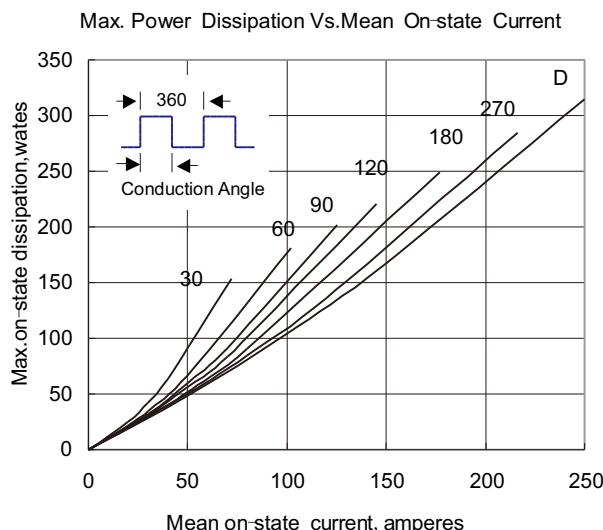


Fig. 5

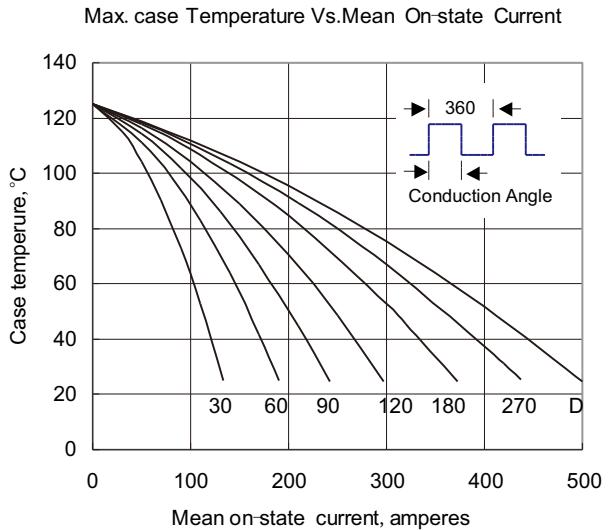


Fig. 6

Rating and Characteristic

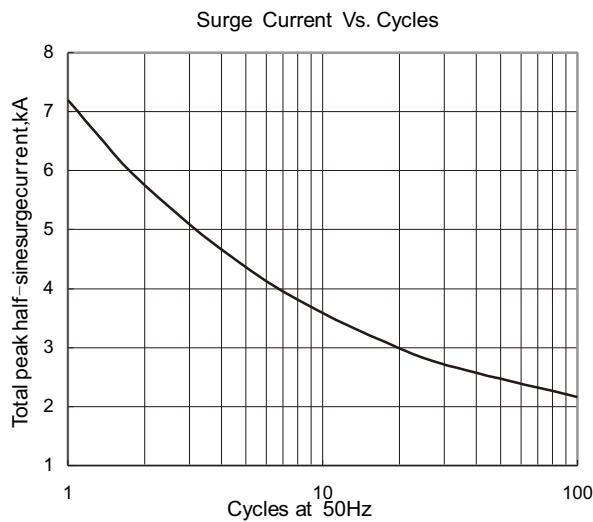


Fig. 7

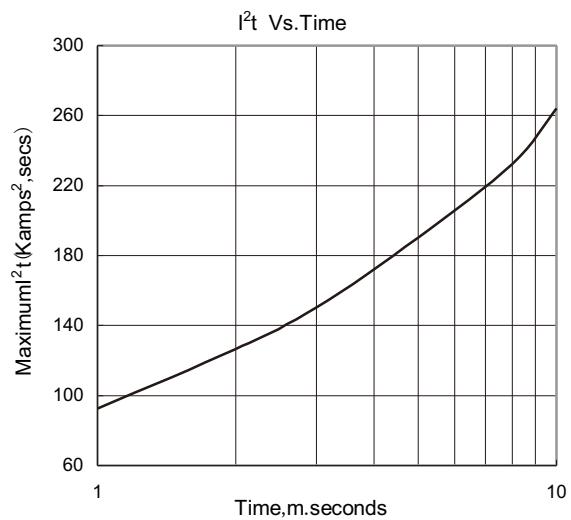


Fig. 8

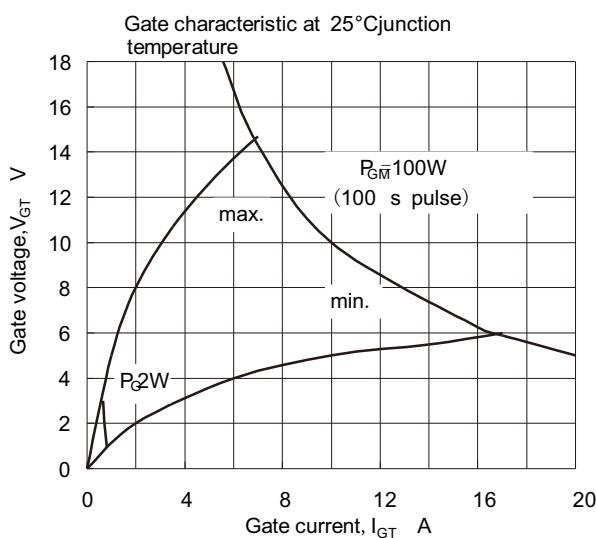


Fig. 9

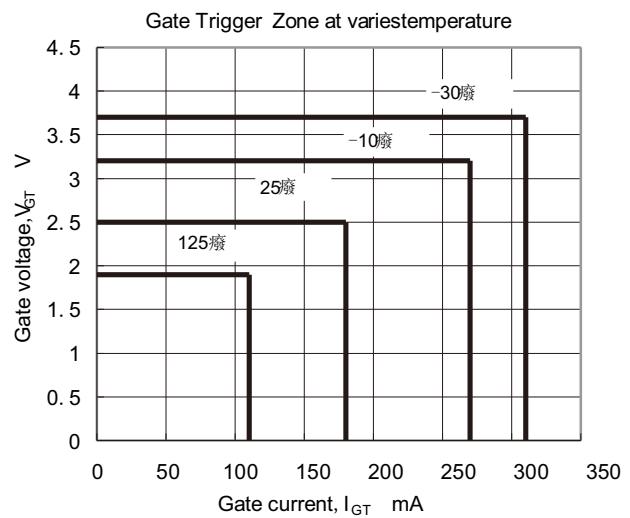


Fig. 10

Outside Dimension

